Search Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/692,573	LI ET AL.	
Examiner	Art Unit	
Michael D. Burkhart	1633	

SEARCHED			
Class	Subclass	Date	Examiner
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		4	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Derwent key	Pat, EPO,JPO, word search ST)	8/14/2006	MS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated inventor name search, see search printout (EAST).	8/14/2006	M
Updated USPat, USPgPub,EPO,JPO, Derwent keyword search (EAST), see search printout.	1	
Allowance conference (D. Nguyen, S. Priebe).	8/11/06	V